

Search Notes

Application/Control No.

10/782,858

Examiner

Habte Mered

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	475	6/23/2007	HM
370	354	6/23/2007	
370	338	6/23/2007	
370	349	6/23/2007	
370	395.53	6/23/2007	
370	329	6/23/2007	
709	245	6/23/2007	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched EAST DB:USPAT, USPGPUB, JPO, and EPO	6/23/2007	HM
Searched Palm Inventor's DB	6/23/2007	HM
Searched IEEE	6/23/2007	
		HM